

Computation of Diffraction Parameter as a Function of Line of Site Percentage Clearance

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Abstract

In this paper, mathematical expression and method for computing diffraction parameter as a function of line of site percentage clearance is presented. The concept of line of site percentage clearance scaling factor is introduced. The scaling factor makes it possible to determine the diffraction parameter at different of line of site percentage clearances when the value of diffraction parameter is known at one particular line of site percentage clearance. Particularly, for Fresnel zone n and line of site percentage given as $P_{c(x,n)}$, the diffraction parameter, $V_{(x,pc)}$ is given as $V_{(x,pc)} = \left(\frac{(\sqrt{2n})P_{c(x,n)}}{100} \right)$. Also, for any two line of site percentages given as $P_{c(x,n)(1)}$ and $P_{c(x,n)(2)}$, the line of site percentage clearance scaling factor is given as $\left(\frac{P_{c(x,n)(2)}}{P_{c(x,n)(1)}} \right)$. If the diffraction parameter at $P_{c(x,n)(1)}$ is given as $V_{(x,pc1)}$, then the diffraction parameter at $P_{c(x,n)(2)}$ is given as $V_{(x,pc2)} = V_{(x,pc1)} \left(\frac{P_{c(x,n)(2)}}{P_{c(x,n)(1)}} \right)$. The mathematical expressions and method are applied to a 3 GHz microwave link with path length of 38887.6 m. The results obtained demonstrated the validity of the mathematical expressions and method presented in the paper.

Keywords: Diffraction Parameter; Fresnel Zone; Microwave Link; Percentage Clearance; Line of Site Communication

1. Introduction

Microwave refers to wavelengths of the electromagnetic spectrum between one meter and one centimeter [1,2]. Generally, microwave signals travel in straight lines. As such in microwave communication system line-of-sight path is required [1,3,4]. In microwave Line Of Site (LOS) communication systems, it is required that a certain clearance be established between the line of site and any obstruction in the signal path. Research findings have shown that obstructions below the line of site can still cause reduction in the received signal strength even when the obstruction tip is below the line of site [5,6]. Accordingly, during microwave LOS communication network planning, it is always necessary to determine the effect of obstructions along the signal path. In this case, the effect of obstruction is quantified as diffraction loss which is determined from the diffraction parameter value. In order to determine the diffraction parameter, the detailed path profile and network parameters are required. Particularly, the elevation profile, the

signal frequency, the obstruction height, obstruction location, and the antenna mast height etc. are required. With these parameters, the line of site clearance height is determined along with the diffraction parameter.

Usually, the design specification for LOS link gives the required LOS clearance height in terms of percentage of the radius of the Fresnel zone at any given location along the signal path. In quick link planning situations, it is desired to specify the LOS clearance requirement in terms of the LOS percentage clearance. In that case, the detailed link and path profile dataset are not required. In this paper, the mathematical expressions that can be used to determine the diffraction parameter as a function of LOS percentage clearance is derived.

Furthermore, in this paper, the concept of LOS percentage clearance scaling factor is introduced. In this case, the LOS percentage clearance enables the diffraction parameter to be determined at any other LOS percentage clearance one the diffraction parameter is known at any one LOS percentage clearance. The derivation and application of the LOS percentage clearance scaling factor are presented in this paper.

2. Theoretical Background

2.1. The Mathematical Expression for Computing Diffraction Parameter as a Function of Line of Site Percentage Clearance

For Line Of Site (LOS) communication link the radius of the nth Fresnel zone ($r(n)$) is given as [5];

$$r(n) = \sqrt{\frac{n\{\lambda(d_{t(x)})(d_{r(x)})\}}{(d_{t(x)} + d_{r(x)})}} \quad (1)$$

where

$d_{t(x)}$ is the distance of location x from the transmitter

$d_{r(x)}$ is the distance of location x from the receiver, where $x = 1, 2, 3, \dots, N$.

N is the number of elevation point in the elevation profile dataset.

n is the nth Fresnel zone

λ is the wavelength of the radio wave in metres where;

$$\lambda = \frac{c}{f} \quad (2)$$

where, c is the speed of a radio wave ($c = 3 \times 10^8 \text{ m/s}$);

f is frequency of the radio wave in Hz.

At any given location x between the transmitter and the receiver, the Fresnel-Kirchoff diffraction parameter is given as $V(x)$ where [5];

$$V(x) = h(x) \left(\sqrt{\frac{2(d_{t(x)} + d_{r(x)})}{\lambda(d_{t(x)})(d_{r(x)})}} \right) \quad (3)$$

where

$h(x)$ is effective obstruction clearance height which is the height (in meters) from the tip of the obstruction at location x to a point on the line of sight at location x, where x is between the transmitter and the receiver.

λ is the wavelength of the radio wave in metres

Let $P_{c(x,n)}$ be the percentage LOS clearance for Fresnel zone n at location x from the

transmitter. In practice, at least 60% of first Fresnel zone radius, $\mathbf{r}_{(1)}$ (that is, 0.6 of $\mathbf{r}_{(1)}$) clearance is required to achieve clear line of sight transmission. The percentage clearance specified with respect to $\mathbf{r}_{(n)}$, the radius of any given Fresnel zone n, is denoted as $P_{c(x,n)}$. The line of sight clearance height at point x computed with respect to $P_{c(x,n)}$ is denoted as $h_{LSC(x,pc)} = \frac{P_{c(x,n)}}{100} (\mathbf{r}_{(n)})$ where:

$$h_{LSC(x,pc)} = \left(\frac{P_{c(x,n)}}{100} \right) \left(\sqrt{\frac{n\{\lambda(d_t(x))(d_r(x))\}}{(d_t(x) + d_r(x))}} \right) \quad (4)$$

Hence, for $P_{c(x,n)} = 60\%$, $h_{LSC(x,60)} = 0.6(\mathbf{r}_{(n)})$. In terms of $P_{c(x,n)}$, the Fresnel-Kirchoff diffraction parameter at any given location x between the transmitter and the receiver can be represented as $(V_{(x,pc)})$ and from Eq 3 it is given as:

$$V_{(x,pc)} = h_{LSC(x,pc)} \left(\sqrt{\frac{2(d_t(x) + d_r(x))}{\lambda(d_t(x))(d_r(x))}} \right) \quad (5)$$

$$V_{(x,pc)} = \left(\frac{P_{c(x,n)}}{100} \right) \left(\sqrt{\frac{n\{\lambda(d_t(x))(d_r(x))\}}{(d_t(x) + d_r(x))}} \right) \left(\sqrt{\frac{2(d_t(x) + d_r(x))}{\lambda(d_t(x))(d_r(x))}} \right) \quad (6)$$

$$V_{(x,pc)} = \left(\frac{P_{c(x,n)}}{100} \right) \left\{ \sqrt{n} \left(\sqrt{\frac{\{\lambda(d_t(x))(d_r(x))\}}{(d_t(x) + d_r(x))}} \right) \right\} \left\{ \sqrt{2} \left(\sqrt{\frac{(d_t(x) + d_r(x))}{\lambda(d_t(x))(d_r(x))}} \right) \right\} \quad (7)$$

$$V_{(x,pc)} = \left(\frac{P_{c(x,n)}}{100} \right) (\sqrt{n})(\sqrt{2}) \left(\sqrt{\frac{\{\lambda(d_t(x))(d_r(x))\}}{(d_t(x) + d_r(x))}} \right) \left(\sqrt{\frac{(d_t(x) + d_r(x))}{\lambda(d_t(x))(d_r(x))}} \right) \quad (8)$$

$$V_{(x,pc)} = \left(\frac{(\sqrt{2n})P_{c(x,n)}}{100} \right) \quad (9)$$

$$P_{c(x,n)} = \frac{(V_{(x,pc)})100}{\sqrt{2n}} \quad (10)$$

For Fresnel zone 1, n=1, then:

$$V_{(x,pc)} = \left(\frac{(\sqrt{2})P_{c(x,n)}}{100} \right) \quad (11)$$

2.2. Line of Site Percentage Clearance Scaling Factor for Computing Diffraction Parameter

Consider $P_{c(x,n)(1)}$ which denotes the LOS percentage clearance given with respect to a given Fresnel zone, n and $V_{(x,pc1)}$ denotes the diffraction parameter computed with respect to $P_{c(x,n)(1)}$, then:

$$V_{(x,pc1)} = \sqrt{2n} \left(\frac{P_{c(x,n)(1)}}{100} \right) \quad (12)$$

Similarly, another LOS percentage clearance, $P_{c(x,n)(2)}$ given with respect to the same Fresnel zone, n, has the diffraction parameter $V_{(x,pc2)}$ which is given as:

$$V_{(x,pc1)} = \sqrt{2n} \left(\frac{P_{c(x,n)(2)}}{100} \right) \quad (13)$$

The $V_{(x,pc2)}$ can be computed with respect to $V_{(x,pc1)}$ as follows:

$$\frac{V_{(x,pc1)}}{V_{(x,pc2)}} = \frac{\sqrt{2n} \left(\frac{P_{c(x,n)(2)}}{100} \right)}{\sqrt{2n} \left(\frac{P_{c(x,n)(1)}}{100} \right)} = \frac{P_{c(x,n)(2)}}{P_{c(x,n)(1)}} \quad (14)$$

$$V_{(x,pc2)} = V_{(x,pc1)} \left(\frac{P_{c(x,n)(2)}}{P_{c(x,n)(1)}} \right) \quad (15)$$

Therefore, $\frac{P_{c(x,n)(2)}}{P_{c(x,n)(1)}}$ is the LOS percentage clearance scaling factor for computing diffraction parameter at different percentage clearance values.

3. Result and Discussion

Table 1 shows the diffraction parameter, V, computed by the two methods. The first method is the existing method which uses the LOS clearance height, $h_{LSC(x,pc)}$, wavelength, distance from the transmitter and distance from receiver to V. The second approach is the method proposed in this paper which computes V by using only the LOS percentage clearance ($P_{c(x,n)}$) and the Fresnel zone n with which the percentage clearance is specified. The results in Table 1 is for a link with path length of 38887.6 m. For the LOS percentage clearance in the table, a location at the middle of the link is considered where the distance from the transmitter = distance from receiver = 19443.79 m. The percentage clearance is considered for the first Fresnel zone where n = 1. The signal frequency is 3 GHz, speed of light is $c = 3 \times 10^8 \text{ m/s}$ such that the wavelength is 0.1 m. The radius of the first Fresnel zone at the point considered (that is, the middle of the link) is computed as 31.18 m.

Table 1 Diffraction Parameters Computed by the Existing Method and by the New Method

S/N	Computed by Specifying LOS Clearance Height			Computed by Specifying LOS Percentage Clearance		
	Specified ($h_{LSC(x,pc)}$) LOS Clearance Height (m)	Computed ($P_{c(x,n)}$) LOS Percentage Clearance (%)	Diffraction Parameter, (V), where $V = h_{LSC} \left(\sqrt{\frac{2(d_t(x) + d_r(x))}{\lambda(d_t(x))(d_r(x))}} \right)$	Specified ($P_{c(x,n)}$) LOS Percentage Clearance (%)	Diffraction Parameter (V) where $V = \left(\frac{(\sqrt{2n})P_{c(x,n)}}{100} \right) n = 1$	Computed ($h_{LSC(x,pc)}$) LOS Clearance Height (m)
1	0	0	0.000	0	0.000	0.0
2	-5	-16.04	-0.227	-16.04	-0.227	-5.0
3	-10	-32.07	-0.454	-32.07	-0.454	-10.0
4	-15	-48.11	-0.680	-48.11	-0.680	-15.0
5	-20	-64.14	-0.907	-64.14	-0.907	-20.0
6	-25	-80.18	-1.134	-80.18	-1.134	-25.0
7	-30	-96.22	-1.361	-96.22	-1.361	-30.0
8	-35	-112.25	-1.587	-112.25	-1.587	-35.0
9	-40	-128.29	-1.814	-128.29	-1.814	-40.0
10	-45	-144.32	-2.041	-144.32	-2.041	-45.0
11	-50	-160.36	-2.268	-160.36	-2.268	-50.0
12	-55	-176.4	-2.495	-176.4	-2.495	-55.0
13	-60	-192.43	-2.721	-192.43	-2.721	-60.0
14	-65	-208.47	-2.948	-208.47	-2.948	-65.0

Table 1 shows that the values of the diffraction parameter, V, obtained by the two methods are the same. For instance, when LOS clearance height is specified as -15 m, the diffraction parameter obtained is -0.68. At that point, with radius of first Fresnel zone as 31.18 m, the percentage clearance with respect to the first Fresnel zone is computed as

-48.11%. Conversely, by specifying percentage clearance of -48.11% with respect to the first Fresnel zone, the diffraction parameter obtained is again -0.68 and the LOS clearance height obtained is -15 m.

The graph plot of the computed diffraction parameter obtained from the specified LOS clearance and the computed LOS percentage clearance (%) is given in Figure 1. The trendline fitted to the graph shows that

$$V = 0.0141 [P_{c(x,n)}] = \frac{1.41}{100} [P_{c(x,n)}] = \frac{\sqrt{2}}{100} [P_{c(x,n)}]$$

In this case, the model, $V = \frac{\sqrt{2}}{100} [P_{c(x,n)}]$ is now generated graphically based on the results obtained when the LOS clearance height is given and then used to compute V and $P_{c(x,n)}$. Essentially, Figure 1 is a graphical validation of the proposed model for computing the diffraction parameter based on LOS percentage clearance.

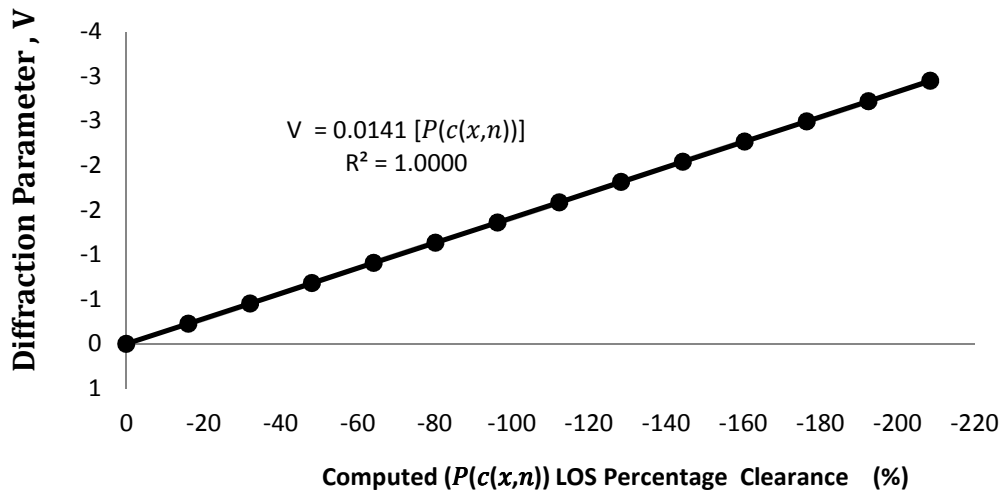


Figure 1 The Diffraction Parameter, V, versus Computed $P_{c(x,n)}$, LOS Percentage Clearance (%)

In Table 2, the diffraction parameter is computed for different percentage clearance. Also, the diffraction parameter is computed based on the diffraction parameter at LOS percentage clearance of -48.11%. At -48.11% clearance with respect to Fresnel zone 1 the diffraction parameter is -0.680. At -128.29% clearance with respect to Fresnel zone 1 the diffraction parameter is given as $0.680 \left(\frac{-128.29}{-48.11} \right) = 1.81$. The result is the same as the diffraction loss obtained earlier with -128.29% percentage clearance. In this case, the LOS percentage clearance scaling factor $\frac{-128.29}{-48.11}$ is used to determine the diffraction parameter at -128.29% when the diffraction parameter at -48.11% is given as 0.680.

4. Conclusion

Mathematical expression and method for computing diffraction parameter as a function of line of site percentage clearance is presented. Also, the method for computing diffraction parameter at different line of site percentage clearance by using the line of site percentage clearance scaling factor is presented. The ideas presented in this paper make it easier to specify and compute the diffraction parameter and other allied parameters needed in the determination of diffraction loss for line of site communication links.

Table 2 Validation Result for the LOS Percentage Clearance Scaling Factor

S/N	Computed by Specifying LOS Percentage Clearance			Computed by LOS Percentage Clearance Scaling Factor			
	Specified LOS Percentage Clearance (%)	Diffraction Parameter, V	Computed LOS Clearance Height (m)	LOS Percentage Clearance 1, P(x,1)(1)	V(x,1) (Diffraction Parameter at LOS Percentage Clearance 1)	LOS Percentage Clearance 2, P(x,1)(2)	V(x,2) (Diffraction Parameter at LOS Percentage Clearance 2)
1	0	0.000	0.0	-48.11	-0.680	0	0.00
2	-16.04	-0.227	-5.0	-48.11	-0.680	-16.04	-0.23
3	-32.07	-0.454	-10.0	-48.11	-0.680	-32.07	-0.45
4	-48.11	-0.680	-15.0	-48.11	-0.680	-48.11	-0.68
5	-64.14	-0.907	-20.0	-48.11	-0.680	-64.14	-0.91
6	-80.18	-1.134	-25.0	-48.11	-0.680	-80.18	-1.13
7	-96.22	-1.361	-30.0	-48.11	-0.680	-96.22	-1.36
8	-112.25	-1.587	-35.0	-48.11	-0.680	-112.25	-1.59
9	-128.29	-1.814	-40.0	-48.11	-0.680	-128.29	-1.81
10	-144.32	-2.041	-45.0	-48.11	-0.680	-144.32	-2.04
11	-160.36	-2.268	-50.0	-48.11	-0.680	-160.36	-2.27
12	-176.4	-2.495	-55.0	-48.11	-0.680	-176.4	-2.49
13	-192.43	-2.721	-60.0	-48.11	-0.680	-192.43	-2.72
14	-208.47	-2.948	-65.0	-48.11	-0.680	-208.47	-2.95

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